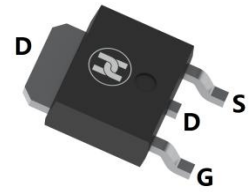
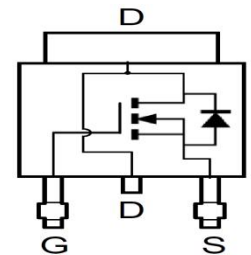


N-CHANNEL HIGH VOLTAGE MOSFET
FEATURES

- $V_{DS}=200V, R_{DS(ON)} \leq 750m\Omega @ V_{GS}=10V, I_D=2.3A$
- Low input capacitance
- Low on-resistance and Low gate drive voltage (Logic level capable)
- Fast switching speed
- High avalanche energy pulse withstand capability
- For Power Management Functions and SLIC line drivers for VoIP applications
- For Transformer Driving Switch and Motor control Applications
- For Uninterrupted power supply Applications
- Surface Mount device


TO-252

MECHANICAL DATA

- Case: TO-252(DPAK)
- Case Material: Molded Plastic. UL flammability
- Classification Rating: 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Weight: 0.33 grams (approximate)

MAXIMUM RATINGS ($T_A = 25^\circ C$ unless otherwise noted)

| Parameter | | Symbol | Value | Unit |
|---|-----------------------------|-----------------|------------|--------------|
| Drain-source voltage | | V_{DS} | 200 | V |
| Gate-source voltage | | V_{GS} | ± 20 | V |
| Continuous drain current, $V_{GS} = 10V$ | $T_c = +25^\circ C$ (Note2) | I_D | 2.3 | A |
| | $T_c = +70^\circ C$ (Note2) | | 1.8 | |
| | $T_c = +25^\circ C$ (Note1) | | 1.5 | |
| Pulsed drain current($V_{GS} = 10V$, Note3) | | I_{DM} | 17.2 | A |
| Single Pulsed Avalanche Energy(Note6) | | E_{AS} | 73 | mJ |
| Single Pulsed Avalanche Current(Note6) | | I_{AS} | 5.5 | A |
| Repetitive Avalanche Energy(Note3) | | E_{AR} | 4.5 | mJ |
| Repetitive Avalanche Current(Note3) | | I_{AR} | 5.5 | A |
| Continuous Source current (Body diode)(Note2) | | I_S | 5.7 | A |
| Pulsed Source current (Body diode)(Note3) | | I_{SM} | 17.3 | A |
| Power dissipation | Note 1 | P_D | 4.3 | W |
| | Note 2 | | 10.2 | |
| | Note 5 | | 2.2 | |
| Thermal resistance from Junction to ambient | Note 1 | $R_{\theta JA}$ | 29.1 | $^\circ C/W$ |
| | Note 2 | | 12.3 | |
| | Note 5 | | 57.3 | |
| Thermal Resistance, Junction to Lead (Note4) | | $R_{\theta JL}$ | 1.15 | $^\circ C/W$ |
| Operating and Storage temperature | | T_J, T_{STG} | -55 ~ +150 | $^\circ C$ |

- Notes: 1. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
2. Same as note 1, except the device is measured at $t \leq 10$ sec.
3. Same as note 1, except the device is operating in a repetitive state with pulse width and duty cycle limited by maximum junction temperature.
4. Thermal resistance from junction to solder-point (at the end of the drain lead).
5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with the high coverage single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
6. UIS in production with $L = 4.83mH, I_{AS} = 5.5A, R_G = 25\Omega, V_{DD} = 100V$, starting $T_J = 25^\circ C$.

N-CHANNEL HIGH VOLTAGE MOSFET
ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise specified)

| Parameter | Symbol | Min | Typ | Max | Unit | Conditions |
|---|----------------------|-----|------|------|------|---|
| OFF CHARACTERISTICS | | | | | | |
| Drain-Source breakdown voltage | V _{(BR)DSS} | 200 | | | V | V _{GS} =0V, I _D =250μA |
| Zero gate voltage drain current | I _{DSS} | | | 0.5 | μA | V _{DS} =200V, V _{GS} =0V |
| Gate-body leakage current | I _{GSS} | | | ±100 | nA | V _{DS} =0V, V _{GS} =±20V |
| ON CHARACTERISTICS | | | | | | |
| Gate-threshold voltage | V _{GS(th)} | 1 | 1.6 | 2.5 | V | V _{DS} =V _{GS} , I _D =250μA |
| Drain-source on-resistance (Note 7) | R _{DS(ON)} | | 650 | 750 | mΩ | V _{GS} =10V, I _D =2.75A |
| | | | 670 | 780 | mΩ | V _{GS} =5V, I _D =2.75A |
| Forward Trans-conductance (Note 7 &8) | g _{fs} | | 6.13 | | S | V _{DS} =30V, I _D =2.75A |
| Diode forward voltage (Note 7) | V _{SD} | | 0.86 | 0.95 | V | I _S =5.5A, V _{GS} =0V |
| Body Diode Reverse Recovery Time(Note8) | t _{rr} | | 177 | | nS | I _S =6.5A, di/dt= 100A/μs |
| Body Diode Reverse Recovery Charge(Note8) | Q _{rr} | | 1.4 | | μC | |
| DYNAMIC CHARACTERISTICS (Note 8) | | | | | | |
| Input capacitance | C _{iss} | | 358 | | pF | V _{DS} =25V, V _{GS} =0V, f=1MHz |
| Output capacitance | C _{oss} | | 50 | | pF | |
| Reverse transfer capacitance | C _{rss} | | 6.1 | | pF | |
| Total gate charge(Note9) | Q _g | | 8.1 | | nC | V _{DS} =120V, V _{GS} =5V, I _D =6.5A |
| Gate-source charge(Note9) | Q _{gs} | | 1.4 | | nC | |
| Gate-drain charge(Note9) | Q _{gd} | | 3.9 | | nC | |
| Turn-on delay time(Note9) | t _{d(on)} | | 17.8 | | nS | V _{DD} =100V, V _{GS} =5V I _D =6.5A, R _g =25Ω |
| Turn-on rise time(Note9) | t _r | | 76.9 | | nS | |
| Turn-off delay time(Note9) | t _{d(off)} | | 44.7 | | nS | |
| Turn-off fall time(Note9) | t _f | | 57.1 | | nS | |

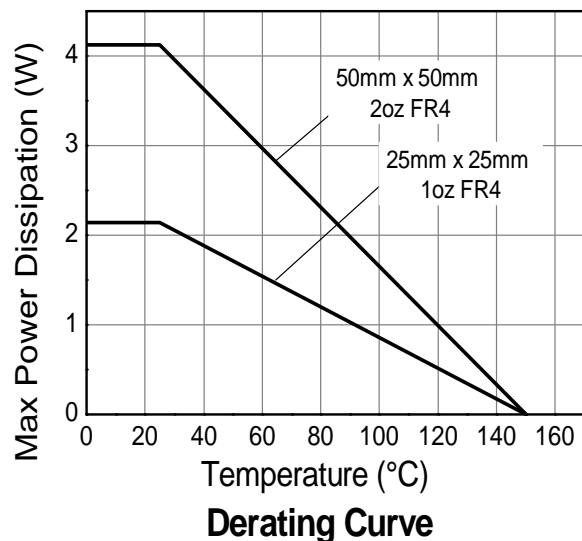
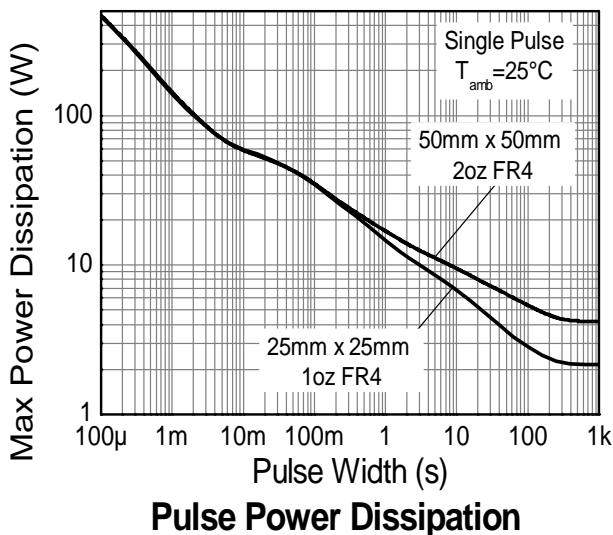
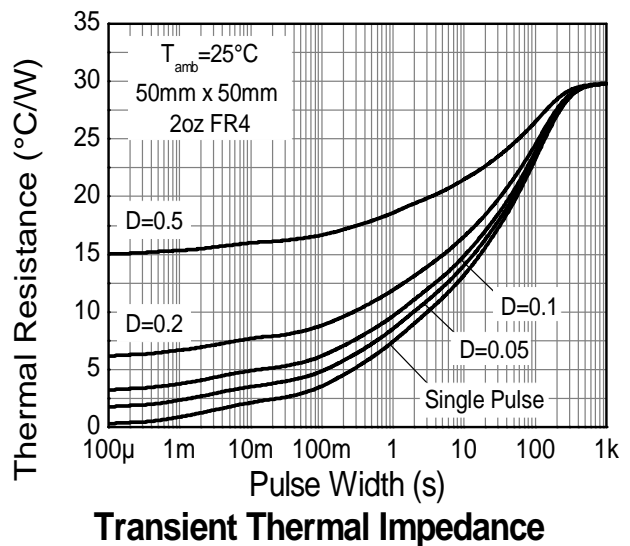
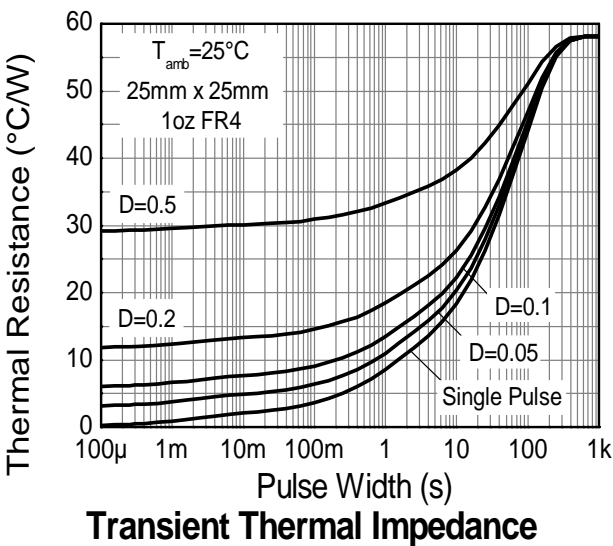
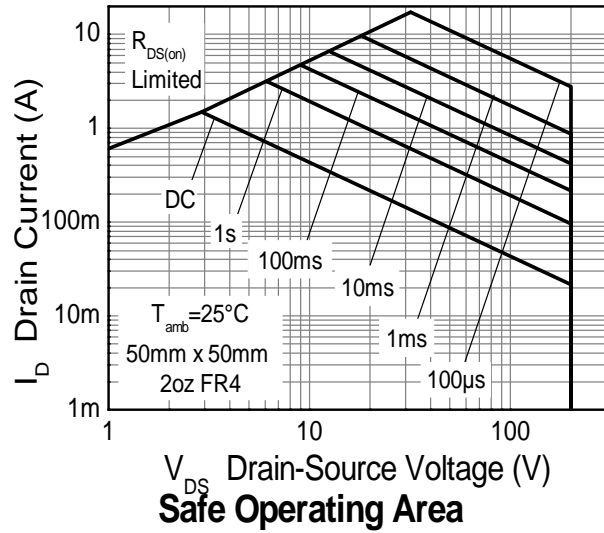
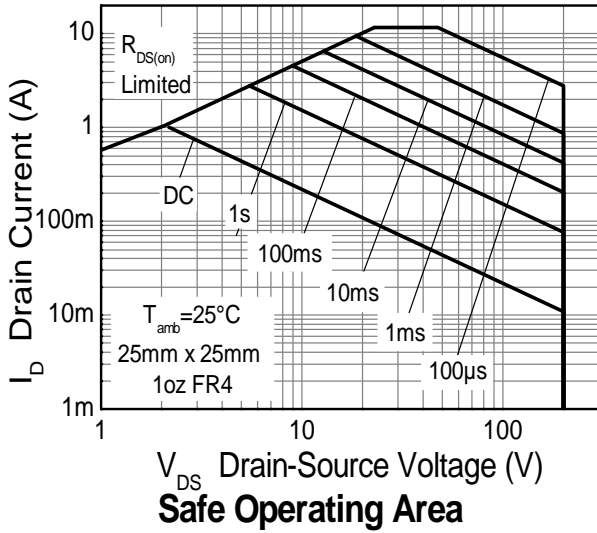
Notes: 7. Measured under pulsed conditions. Pulse width ≤ 300μs; duty cycle ≤ 2%

8. For design aid only, not subject to production testing.

9. Switching characteristics are independent of operating junction temperatures.

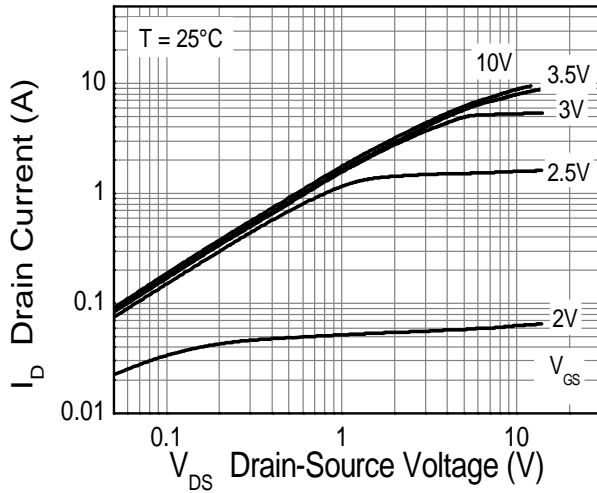
N-CHANNEL HIGH VOLTAGE MOSFET

Thermal Characteristics

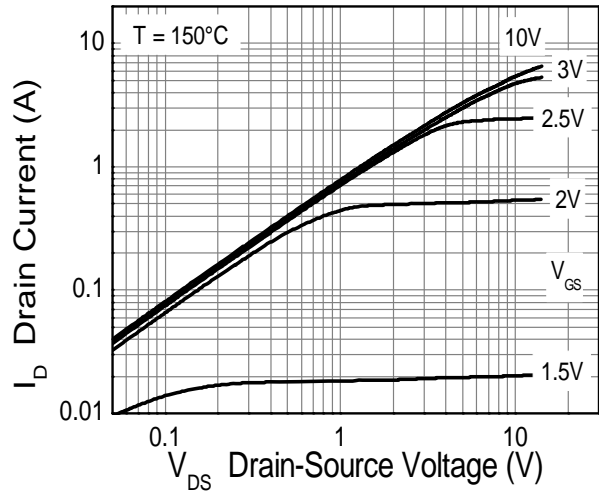


N-CHANNEL HIGH VOLTAGE MOSFET

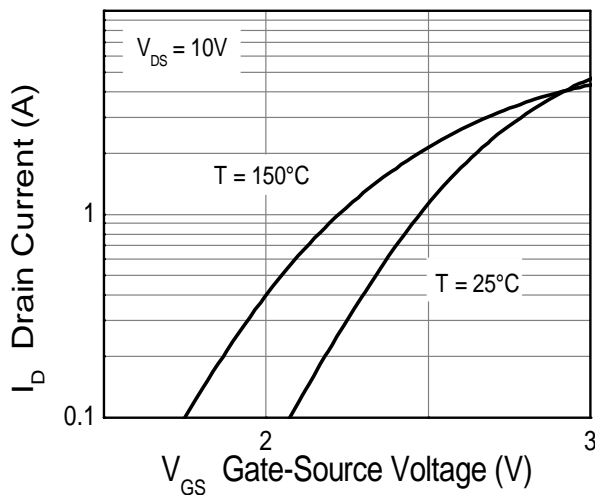
Typical Characteristics



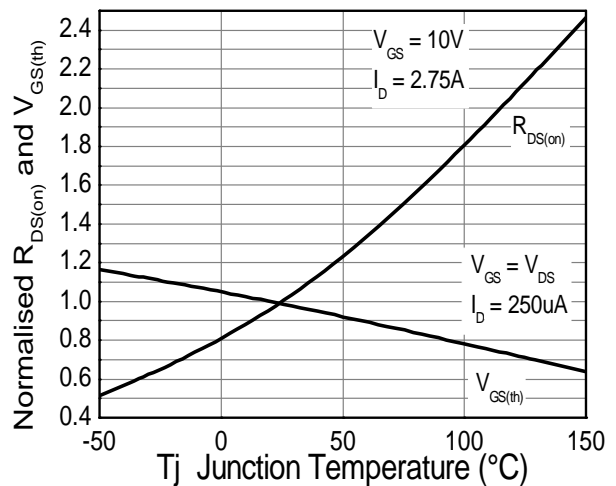
Output Characteristics



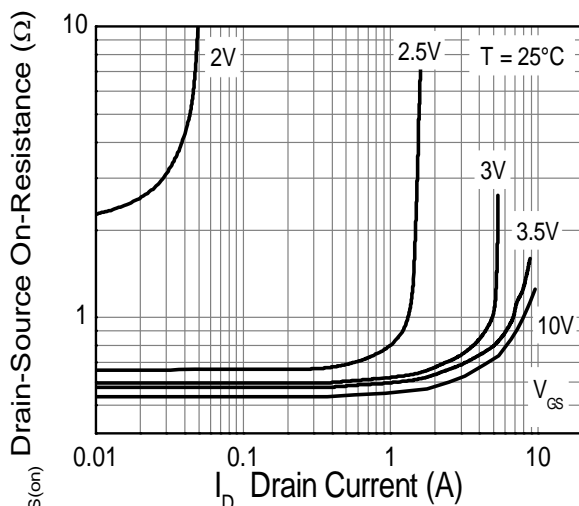
Output Characteristics



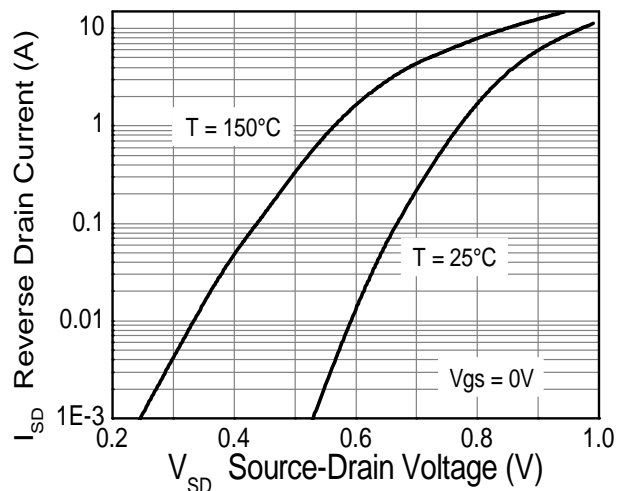
Typical Transfer Characteristics



Normalised Curves v Temperature



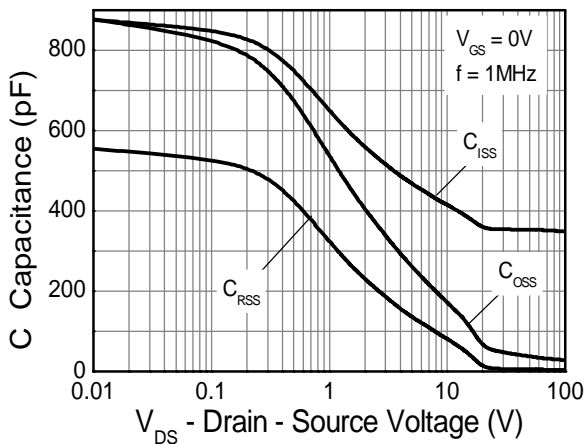
On-Resistance v Drain Current



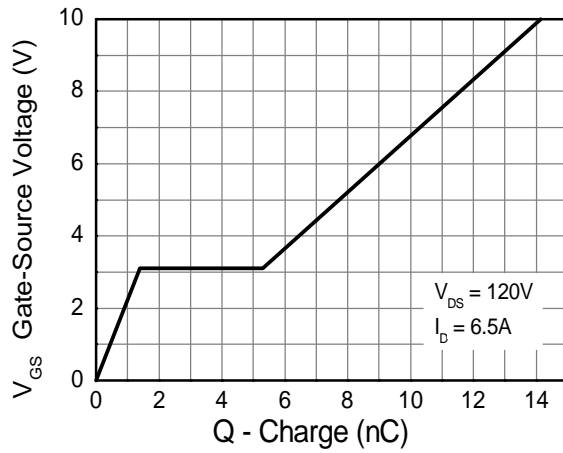
Source-Drain Diode Forward Voltage

N-CHANNEL HIGH VOLTAGE MOSFET

Typical Characteristics - continued

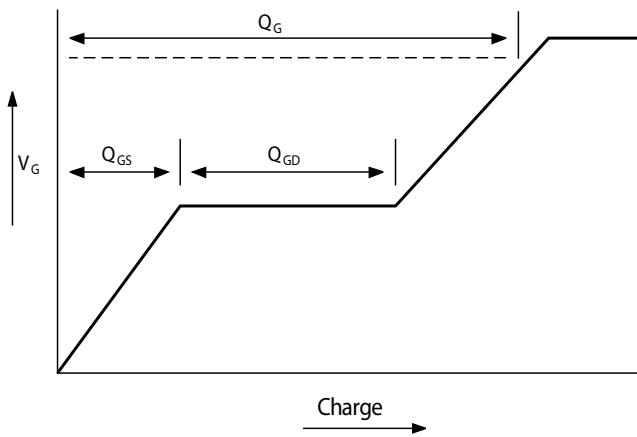


Capacitance v Drain-Source Voltage

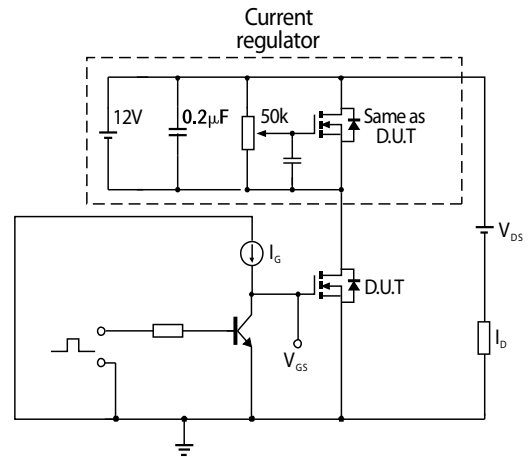


Gate-Source Voltage v Gate Charge

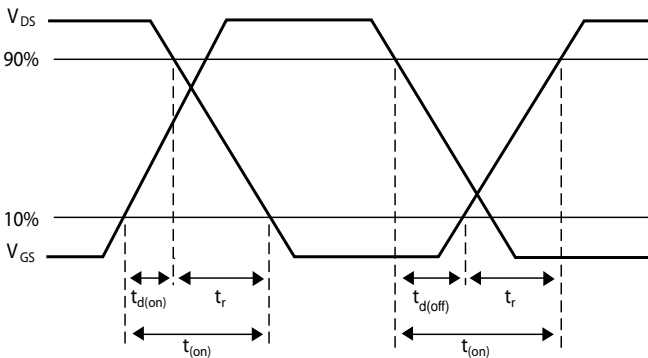
Test Circuits



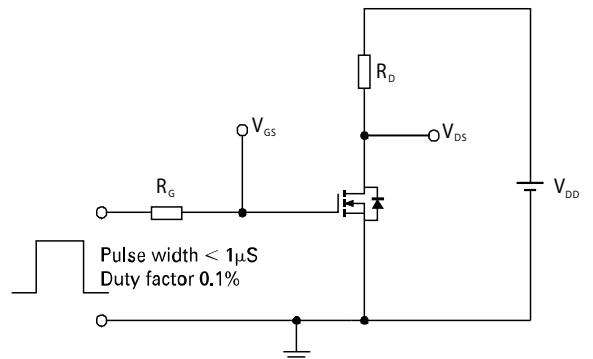
Basic gate charge waveform



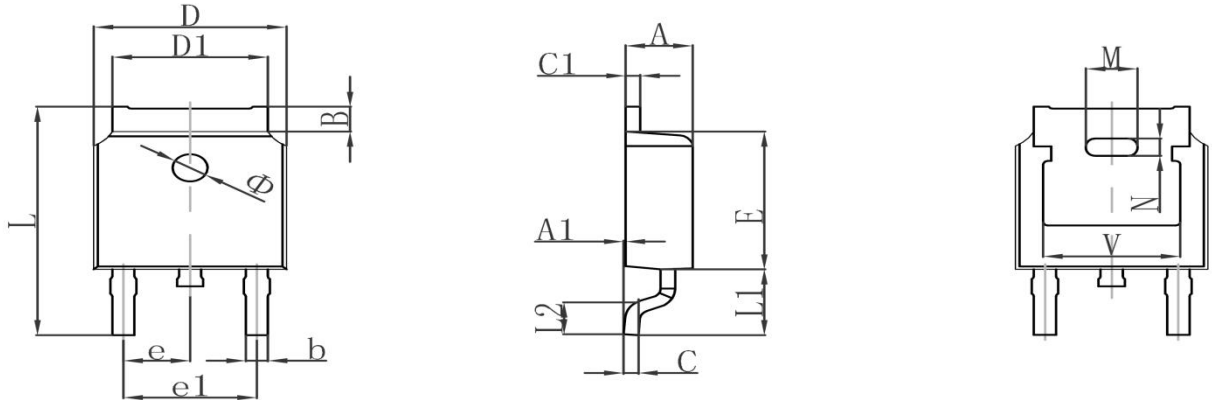
Gate charge test circuit



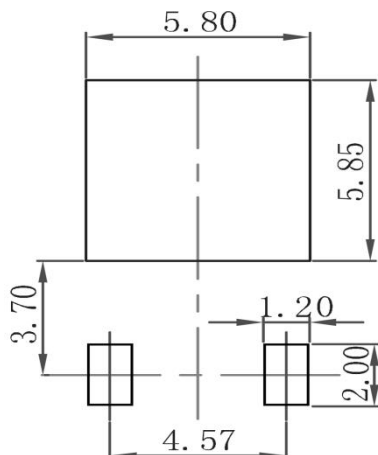
Switching time waveforms



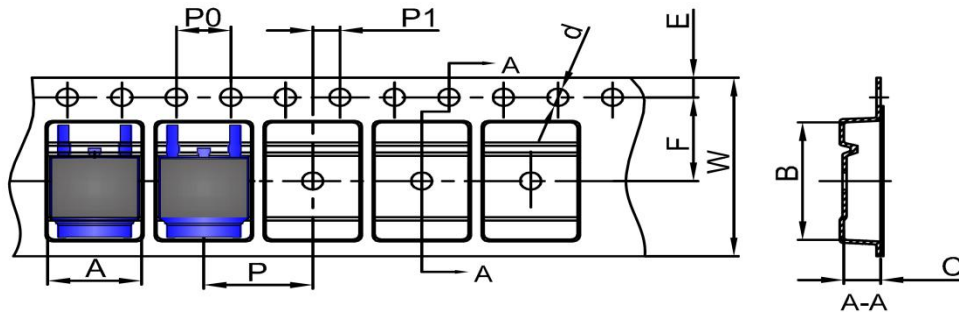
Switching time test circuit

N-CHANNEL HIGH VOLTAGE MOSFET
TO-252 Package Outline Dimensions


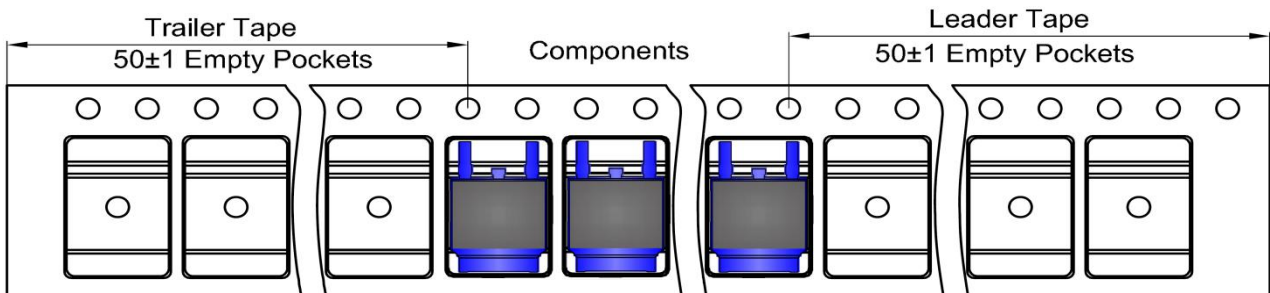
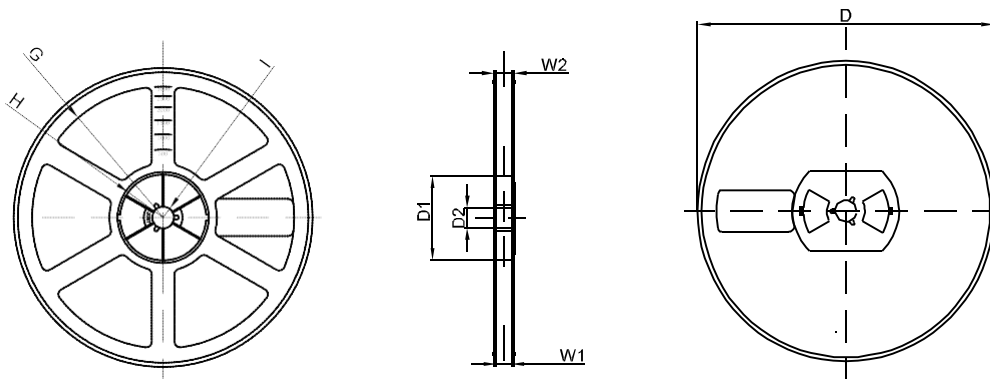
| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|--------|----------------------|-------|
| | Min. | Max. | Min. | Max. |
| A | 2.200 | 2.380 | 0.087 | 0.094 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| B | 0.800 | 1.400 | 0.031 | 0.055 |
| b | 0.710 | 0.810 | 0.028 | 0.032 |
| c | 0.460 | 0.560 | 0.018 | 0.022 |
| c1 | 0.460 | 0.560 | 0.018 | 0.022 |
| D | 6.500 | 6.700 | 0.256 | 0.264 |
| D1 | 5.130 | 5.460 | 0.202 | 0.215 |
| E | 6.000 | 6.200 | 0.236 | 0.244 |
| e | 2.286TYP | | 0.090TYP | |
| e1 | 4.327 | 4.727 | 0.170 | 0.186 |
| M | 1.778REF | | 0.070REF | |
| N | 0.762REF | | 0.018REF | |
| L | 9.800 | 10.400 | 0.386 | 0.409 |
| L1 | 2.9REF | | 0.114REF | |
| L2 | 1.400 | 1.700 | 0.055 | 0.067 |
| V | 4.830REF | | 0.190REF | |
| Φ | 1.100 | 1.300 | 0.043 | 0.051 |

TO-252 Suggested Pad Layout

Note:

1. Controlling dimension: in millimeters
2. General tolerance: $\pm 0.05\text{mm}$
3. The pad layout is for reference purposes only

N-CHANNEL HIGH VOLTAGE MOSFET
TO-252 Tape and Reel
TO-252 Embossed Carrier Tape


| DIMENSIONS ARE IN MILLIMETER | | | | | | | | | | |
|------------------------------|------|-------|------|-------|------|------|------|------|------|-------|
| TYPE | A | B | C | d | E | F | P0 | P | P1 | W |
| TO-252 | 6.90 | 10.50 | 2.70 | Ø1.55 | 1.75 | 7.50 | 4.00 | 8.00 | 2.00 | 16.00 |
| TOLERANCE | ±0.1 | ±0.1 | ±0.1 | ±0.1 | ±0.1 | ±0.1 | ±0.1 | ±0.1 | ±0.1 | ±0.1 |

TO-252 Tape Leader and Trailer

TO-252 Reel


| DIMENSIONS ARE IN MILLIMETER | | | | | | | | |
|------------------------------|---------|--------|--------|---------|--------|-------|-------|-------|
| REEL OPTION | D | D1 | D2 | G | H | I | W1 | W2 |
| 13" DIA | Ø330.00 | 100.00 | Φ21.00 | R151.00 | R56.00 | R6.50 | 16.40 | 21.00 |
| TOLERANCE | ±2 | ±1 | ±1 | ±1 | ±1 | ±1 | ±1 | ±1 |